SUPPORTING INFORMATION

Radical Salt-Doped Hole Transporters In Organic Photovoltaic Devices

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X-Ray Diffraction on PTPD, PTPD/Salt binary and PTPD/Salt/C₆₀ ternary blends:

X-ray diffraction was used to confirm the morphology of the PTPD films in the presence (10 wt%) and absence of TMTPD⁻⁺ SbF₆⁻ radical salt (Figure S1). The PTPD polymer film appears amorphous as evident from the absence of any sharp crystalline peaks in the XRD micrographs. The PTPD/salt binary blend also remains amorphous after the addition of the crystalline small molecule salt.

The XRD micrograph of the film of PTPD/salt/ C_{60} ternary blends with 10 wt% and 50 wt% in salt and C_{60} respectively with respect to PTPD is shown in Figure S2. While the PTPD/salt binary blend shows more of an amorphous nature, the PTPD/salt/ C_{60} ternary blend shows crystalline features which correspond to C_{60} . This suggest that during spin coating the C_{60} readily crystallize out from the amorphous PTPD/salt matrix.

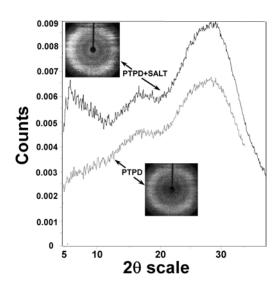


Figure S1: X-ray diffraction data of PTPD polymer and the PTPD/salt binary blend.

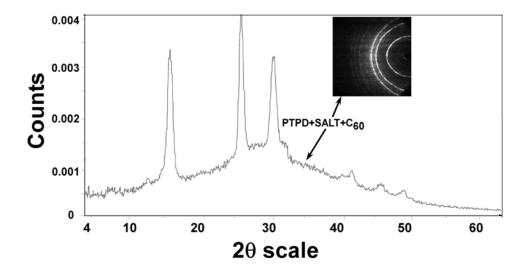


Figure S2: X-ray diffraction of PTPD/salt/ C_{60} ternary blend. The salt and C_{60} in the ternary blend were 10 wt% and 50 wt%, respectively with respect to the PTPD polymer.

Dark J-V Characteristics of ITO/PTPD-Salt/Al Binary Blend and ITO/PTPD-Salt- C_{60} /Al Ternary Blend Devices:

Figure S3 shows the *J-V* characteristics under no illumination of the ITO/PTPD-salt/Al binary mixture devices for various salt concentrations in PTPD. Even though the devices exhibited no photovoltaic behavior, current densities increased with increasing salt concentration because of increased *p*-type conductivity of the PTPD films. Figure S4 shows the *J-V* characteristics under no illumination of the ITO/PTPD-salt-C₆₀/Al ternary mixture devices for various salt concentrations in PTPD. Similar to the ITO/PTPD-salt/Al binary blend devices, the devices exhibited no photovoltaic behavior but the current densities increased with increasing salt concentration.

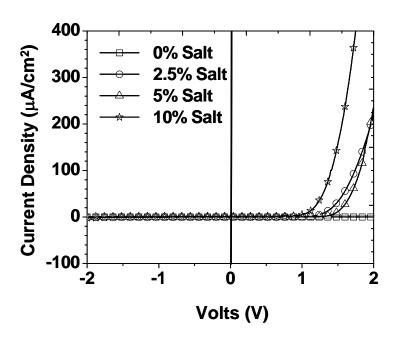


Figure S3: *J-V* characteristics under no illumination of the ITO/PTPD-salt/Al binary blend devices with varying salt concentrations.

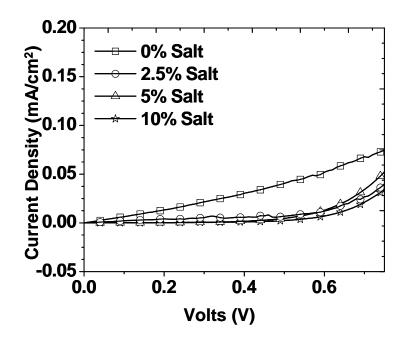


Figure S4: *J-V* characteristics under no illumination of the ITO/PTPD-salt-C₆₀/Al ternary blend devices with varying salt concentration.

Comparison of percent increase in absorption and short circuit current density as a function of salt concentration:

Figure S5 shows the percentage increase in absorption and I_{sc} as function of the salt concentration. As explained in the manuscript, while the increase in salt concentration increases the absorption of the device linearly by c.a. 70% from that of the 0% salt device, the progressive increase in I_{sc} is much higher (c.a. 150%). The latter has been explained by the progressive decrease in series resistance for p type conduction through the PTPD/salt phase.

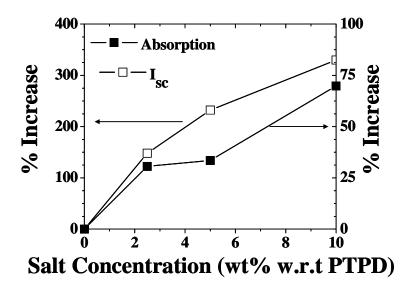


Figure S5: Percentage increase in absorption and I_{sc} as function of the salt concentration in PTPD/salt binary blend devices.

References:

- 1. Kutner, W.; Pieta, P.; Nowakowski, R.; J. Sobczak; Kaszkur, Z.; McCarty, A. L.; D'Souza, F.; Chem. Mater. 2005, 17, 5635.
- 2. Tomura, K.; Nishizawa, M.; Takemura, D.; Matsue, T.; Uchida, I.; *Chem. Lett.* **1994**, 23, 1365.